

NUS5531MT

Main Switch Power MOSFET and Single Charging BJT

–12 V, –6.2 A, Single P–Channel FET with Single PNP low $V_{ce(sat)}$ Transistor, 3x3 mm WDFN Package

This device integrates one high performance power MOSFET and one low $V_{ce(sat)}$ transistor, greatly reducing the layout space and optimizing charging performance in battery-powered portable electronics.

Features

- High Performance Power MOSFET
- Single Low $V_{ce(sat)}$ Transistor as Charging Power Mux
- 3.0x3.0x0.8 mm WDFN Package
- Independent Pin-out Provides Circuit Flexibility
- Low Profile (<0.8 mm) for Easy Fit in Thin Environments
- This is a Pb–Free Device

Applications

- Main Switch and Battery Charging Mux for Portable Electronics
- Optimized for Commercial PMUs from Top Suppliers (See Figure 2)

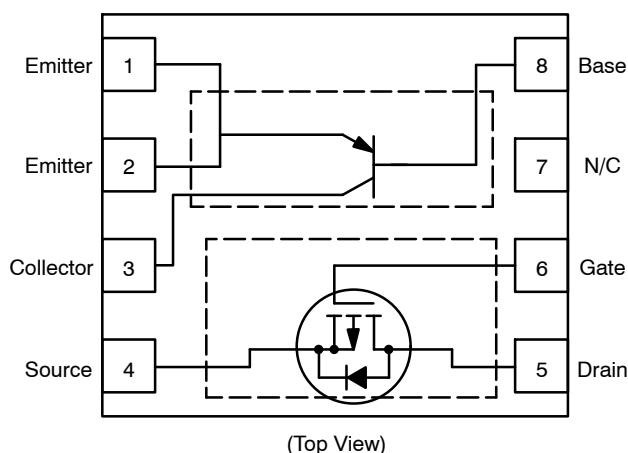


Figure 1. Simple Schematic



ON Semiconductor®

<http://onsemi.com>

MOSFET

$V_{(BR)DSS}$	$R_{DS(on)}$ TYP	I_D MAX
–12 V	32 m Ω @ –4.5 V	–6.2 A
	44 m Ω @ –2.5 V	

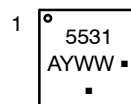
Low $V_{ce(sat)}$ PNP (Wall/USB)

V_{CE0} MAX	V_{EBO} MAX	I_C MAX
–20 V	–7.0 V	–2.0 A



WDFN8
CASE 506BC

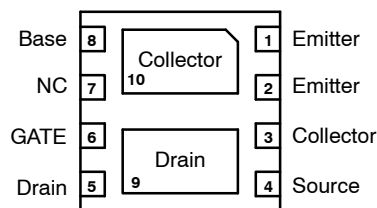
MARKING DIAGRAM



5531 = Device Code
A = Assembly Location
Y = Year
WW = Work Week
▪ = Pb–Free Package

(Note: Microdot may be in either location)

PIN ASSIGNMENT



(Bottom View)

ORDERING INFORMATION

Device	Package	Shipping†
NUS5531MTR2G	WDFN8 (Pb–Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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P-Channel Power MOSFET Maximum Ratings ($T_J = 25^\circ\text{C}$ unless otherwise stated)

Parameter			Symbol	Value	Units
Drain-to-Source Voltage			V _{DSS}	−12	V
Gate-to-Source Voltage			V _{GS}	±8.0	V
Continuous Drain Current (Note 1)	Steady State	T _A = 25°C	I _D	−5.47	A
		T _A = 85°C		−4.0	
	t ≤ 5 s	T _A = 25°C		−6.2	
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	1.46	W
	t ≤ 10 s			2.1	
Continuous Drain Current (Note 2)	Steady State	T _A = 25°C	I _D	−4.4	A
		T _A = 85°C		−3.2	
Power Dissipation (Note 3)	T _A = 25°C		P _D	0.418	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	−25	A
Operating Junction and Storage Temperature			T _J , T _{STG}	−55 to 150	°C
Operating Case Temperature (Note 3)			T _C	−55 to 125	°C
Source Current (Body Diode) ²			I _S	−2.8	A
Lead Temperature for Soldering Purposes (1/8″ from case for 10 s)			T _L	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient – Steady State (Note 3)	$R_{\theta JA}$	299	$^\circ\text{C/W}$
Junction-to-Ambient – $t < 10 \text{ s}$ (Note 3)	$R_{\theta JA}$	81.4	$^\circ\text{C/W}$
Junction-to-Ambient – Steady State (Note 1)	$R_{\theta JA}$	85.5	$^\circ\text{C/W}$
Junction-to-Ambient – $t < 10 \text{ s}$ (Note 1)	$R_{\theta JA}$	58.7	$^\circ\text{C/W}$
Junction-to-Case – $t < 10 \text{ s}$ (Note 3)	ψ_{JC}	26	$^\circ\text{C/W}$

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 sq in [1 oz] including traces).
2. Surface-mounted on FR4 board using 0.5 in sq pad size, 1 oz. Cu.
3. Surface-mounted on FR4 board using 50 sq mm pad size, 1 oz. Cu.

P-Channel MOSFET Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-12.0			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	$I_D = -250 \mu\text{A}$, ref to 25°C		-10.1		$\text{mV}/^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = -12 \text{ V}$			-1.0	μA
		$T_J = 125^\circ\text{C}$			-10	
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 200	nA

ON CHARACTERISTICS (Note 4)

Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = -250 \mu\text{A}$	-0.45	-0.67	-1.1	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$			2.68		$\text{mV}/^\circ\text{C}$
Drain-to-Source On Resistance	$R_{DS(on)}$	$V_{GS} = -4.5 \text{ V}, I_D = -3.0 \text{ A}$		32	40	$\text{m}\Omega$
		$V_{GS} = -2.5 \text{ V}, I_D = -3.0 \text{ A}$		44	50	
Forward Transconductance	g_{FS}	$V_{DS} = -16 \text{ V}, I_D = -3.0 \text{ A}$		5.9		S

4. Pulsed Condition: Pulse Width = 300 μsec , Duty Cycle $\leq 2\%$

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P-Channel MOSFET Electrical Characteristics (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
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CHARGES, CAPACITANCES AND GATE RESISTANCE

Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = -12 V		1329		pF
Output Capacitance	C _{OSS}			200		
Reverse Transfer Capacitance	C _{RSS}			116		
Total Gate Charge	Q _{G(tot)}	V _{GS} = -4.5 V, V _{DS} = -12 V, I _D = -3.0 A		13		nC
Threshold Gate Charge	Q _{G(th)}			1.1		
Gate-to-Source Charge	Q _{GS}			1.7		
Gate-to-Drain Charge	Q _{GD}			2.5		

SWITCHING CHARACTERISTICS

Turn-On Delay Time	t _{d(on)}	V _{GS} = -4.5 V, V _{DD} = -12 V, I _D = -3.0 A, R _G = 3.0		8		ns
Rise Time	t _r			17.5		
Turn-Off Delay Time	t _{d(off)}			80		
Fall Time	t _f			56.5		

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Recovery Voltage	V _{SD}	V _{GS} = 0 V, I _S = -1.0 A	T _J = 25°C		-0.66	-1.2	V
			T _J = 125°C		-0.54		
Reverse Recovery Time	t _{rr}	V _{GS} = 0 V, dI _{SD} /dt = 100 A/μs, I _S = -1.0 A		70.8			ns
Charge Time	t _a			14.3			
Discharge Time	t _b			56.4			
Reverse Recovery Charge	Q _{RR}			44			nC

Single-PNP Transistor Maximum Ratings (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Units
Collector-Emitter Voltage	V _{CEO}	-20	V
Collector-Base Voltage	V _{CBO}	-20	V
Emitter-Base Voltage	V _{EBO}	-7.0	V
Collector Current, Continuous	I _C	-2.0	A
Collector Current, Peak	I _C	-4.0	A
Operating Junction and Storage Temperature	T _J , T _{STG}	-55 to 150	°C
Power Dissipation, T _A = 25°C (Note 5)	P _D	1.58	W
Thermal Resistance (Note 5)	R _{θJA}	61.5	°C/W
Power Dissipation, T _A = 25°C (Note 6)	P _D	0.43	W
Thermal Resistance (Note 6)	R _{θJA}	293	°C/W

5. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 sq in [1 oz] including traces)

6. Surface-mounted on FR4 board using 50 sq mm pad size, 1 oz. Cu.

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Single-PNP Transistor Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
OFF CHARACTERISTICS						
Collector-Emitter Breakdown Voltage	V_{brCEO}	$I_C = -10\text{ mA}, I_B = 0$	-20			V
Collector-Base Breakdown Voltage	V_{brCBO}	$I_C = -0.1\text{ mA}, I_E = 0$	-20			V
Emitter-Base Breakdown Voltage	V_{brEBO}	$I_E = -0.1\text{ mA}, I_C = 0$	-7.0			V
Collector-Emitter Cutoff Current	I_{CES}	$V_{CES} = -15\text{ V}$			-0.1	μA

ON CHARACTERISTICS

DC Current Gain (Note 7)	h_{FE}	$I_C = -1.0\text{ A}, V_{CE} = -2.0\text{ V}$	180			-
DC Current Gain (Note 7)	h_{FE}	$I_C = -2.0\text{ A}, V_{CE} = -2.0\text{ V}$	150			-
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -1.0\text{ A}, I_B = -0.01\text{ A}$		-0.10	-0.12	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -1.0\text{ A}, I_B = -0.1\text{ A}$		-0.065	-0.09	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -2.0\text{ A}, I_B = -0.2\text{ A}$		-0.13	-0.18	V
Base-Emitter Saturation Voltage (Note 7)	$V_{BE(sat)}$	$I_C = -1.0\text{ A}, I_B = -0.01\text{ A}$			-0.9	V
Base-Emitter Turn-On Voltage (Note 7)	$V_{BE(on)}$	$I_C = -1.0\text{ A}, I_B = -2.0\text{ A}$			-0.9	V
Cutoff Frequency (Note 8)	f_T	$I_C = -100\text{ mA}, V_{CE} = -5.0\text{ V}$ $f = 100\text{ MHz}$	100			MHz
Input Capacitance (Note 8)	C_{ibo}	$V_{EB} = -0.5\text{ V}, f = 1.0\text{ MHz}$			330	pF
Output Capacitance (Note 8)	C_{obo}	$V_{CB} = -3.0\text{ V}, f = 1.0\text{ MHz}$			100	pF

7. Pulsed Condition: Pulse Width = 300 μsec , Duty Cycle $\leq 2\%$

8. Guaranteed by design but not tested.

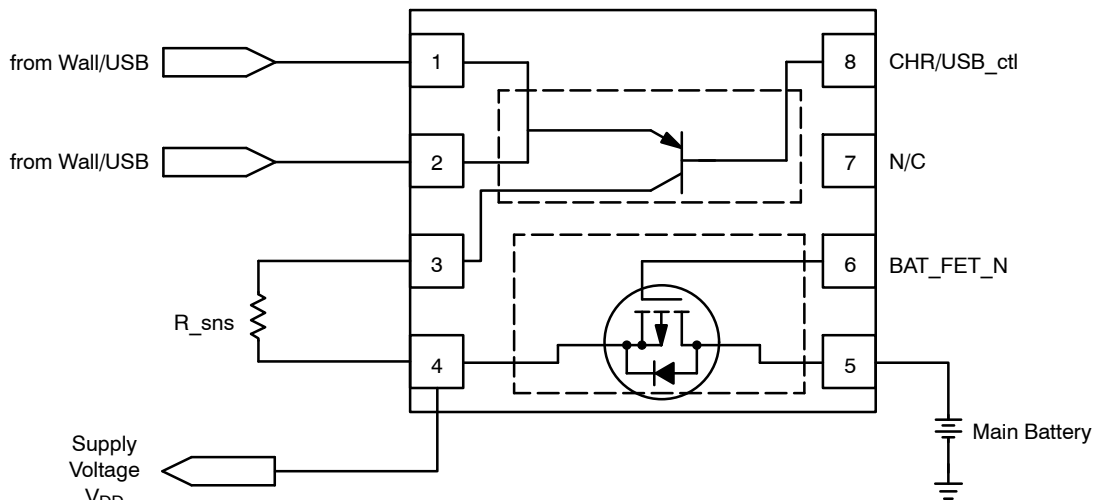


Figure 2. Typical Application Circuit

TYPICAL CHARACTERISTICS – MOSFET

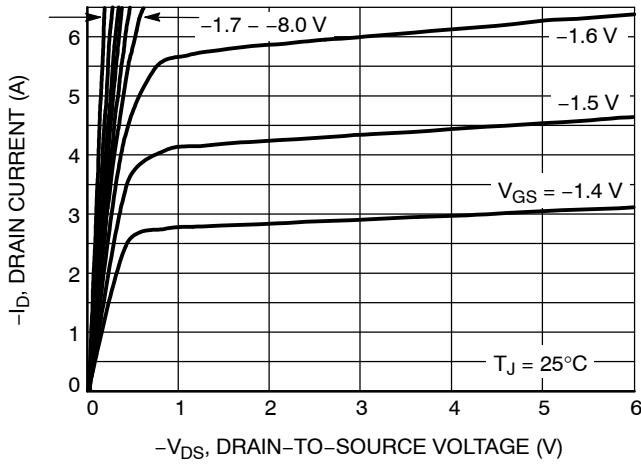


Figure 3. On-Region Characteristics

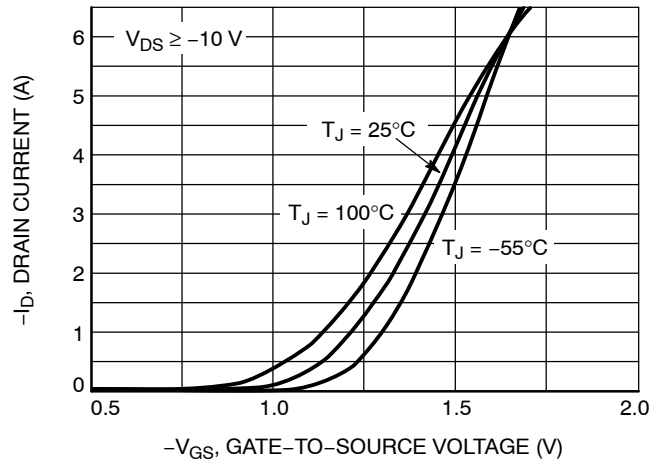


Figure 4. Transfer Characteristics

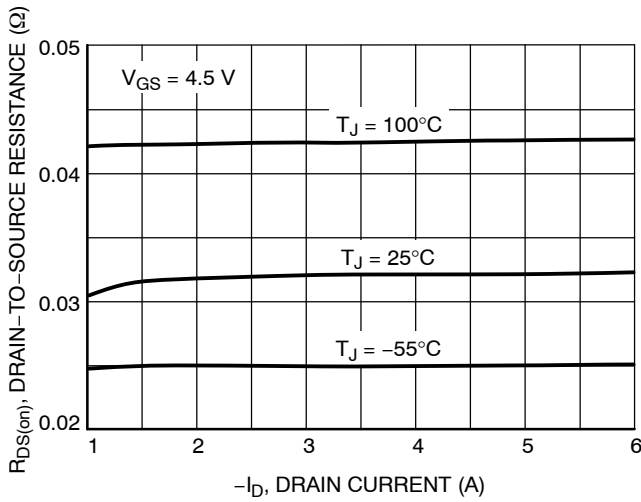


Figure 5. On-Resistance vs. Drain Current

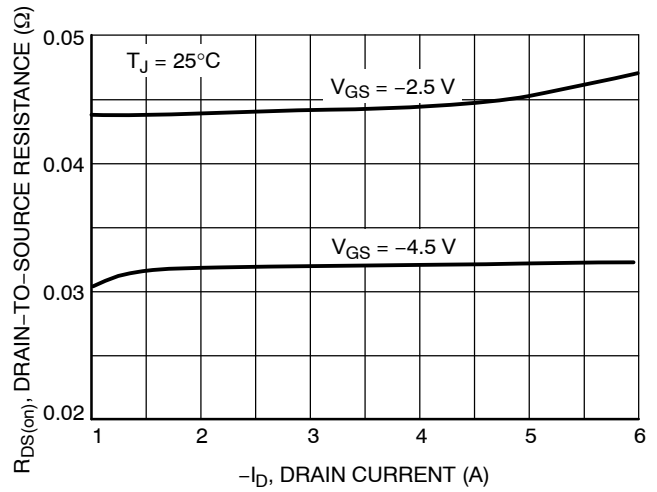


Figure 6. On-Resistance vs. Drain Current and Gate Voltage

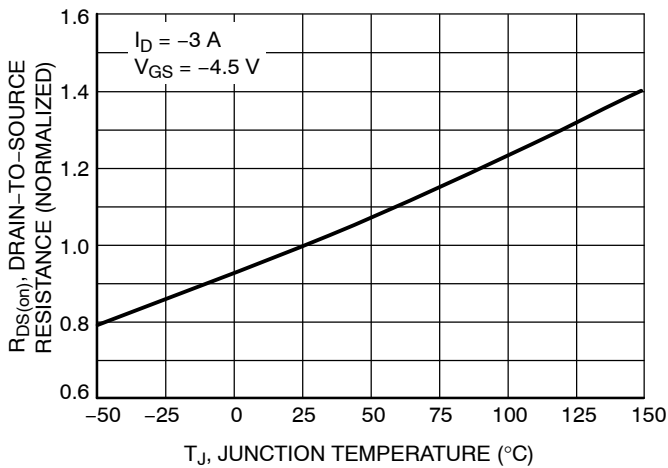


Figure 7. On-Resistance Variation with Temperature

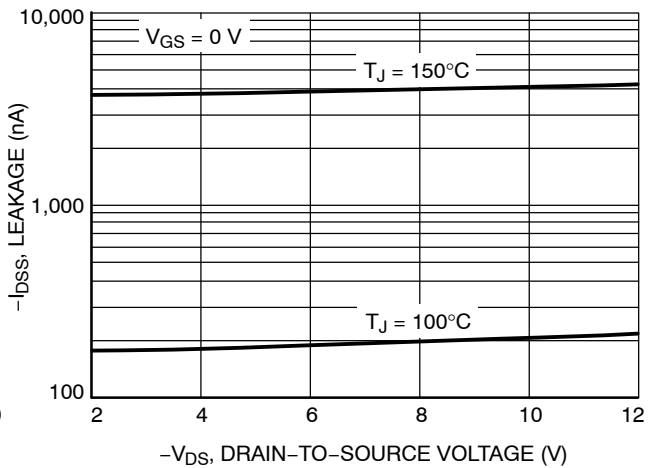


Figure 8. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS – MOSFET

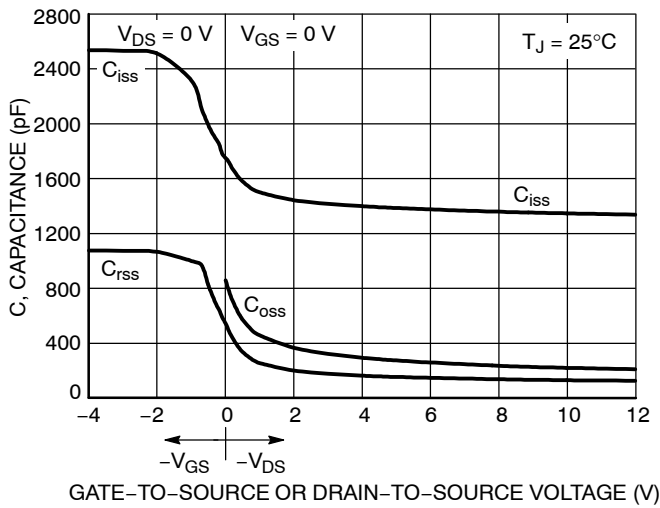


Figure 9. Capacitance Variation

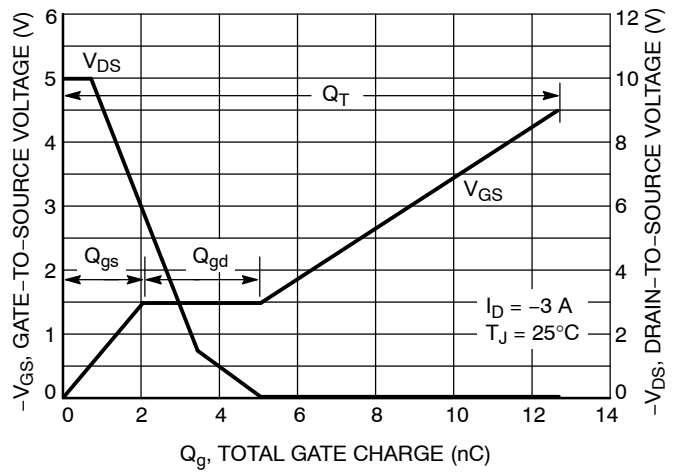


Figure 10. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

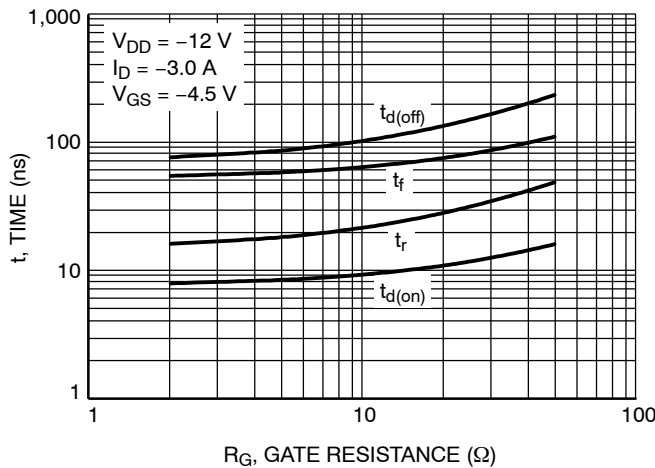


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

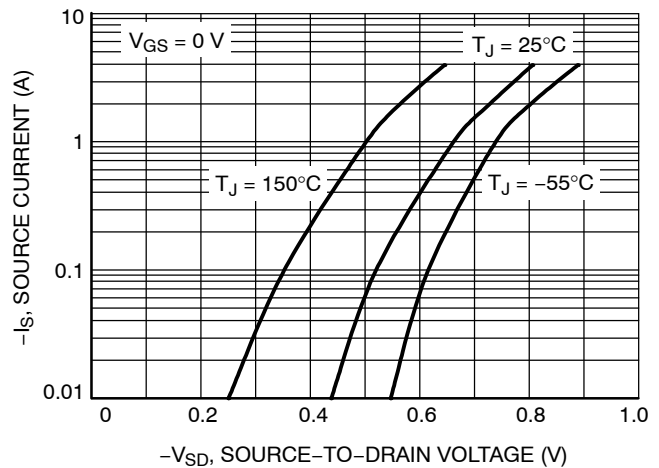


Figure 12. Diode Forward Voltage vs. Current

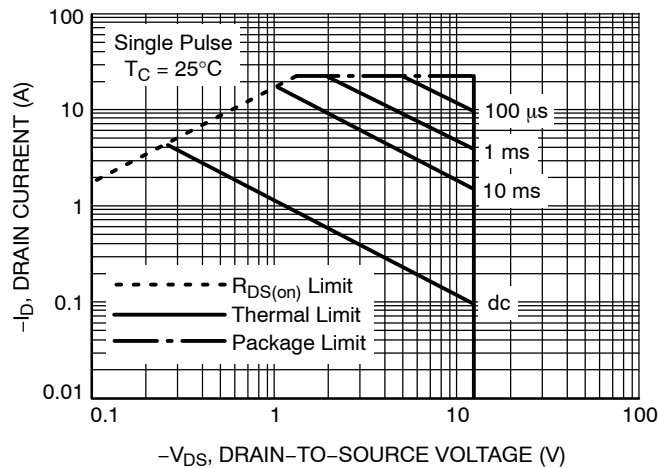


Figure 13. Maximum Rated Forward Biased Safe Operating Area

Mounted on 2" sq.
FR4 board (0.5" sq.
2 oz. Cu single
sided) with MOSFET
die operating.

TYPICAL CHARACTERISTICS – MOSFET

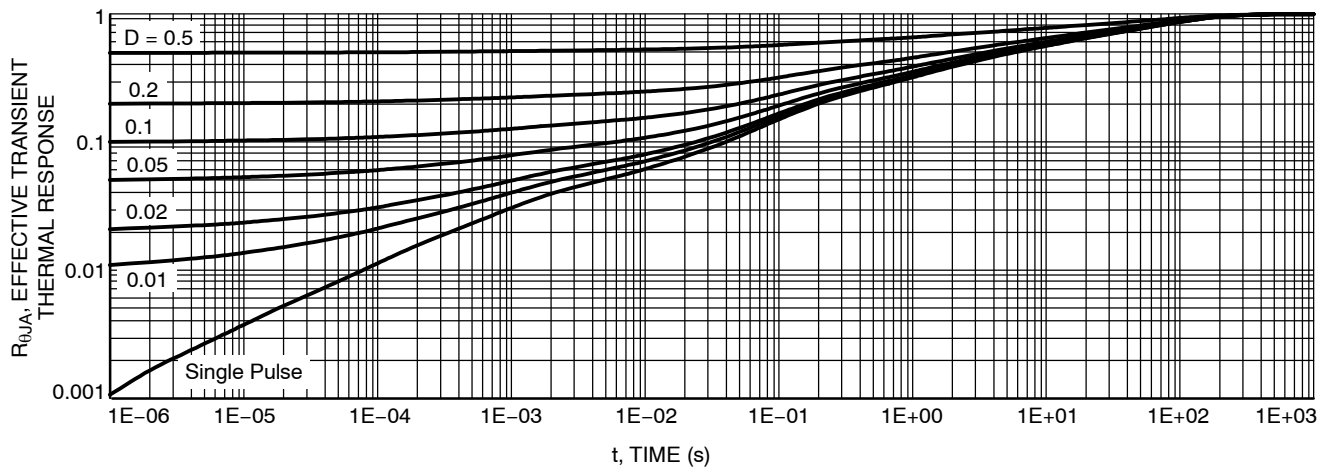


Figure 14. FET Thermal Response

TYPICAL CHARACTERISTICS – BJT

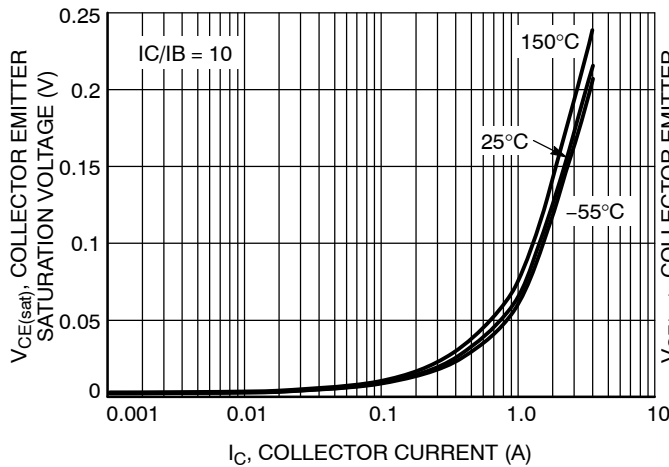


Figure 15. Collector Emitter Saturation Voltage vs. Collector Current

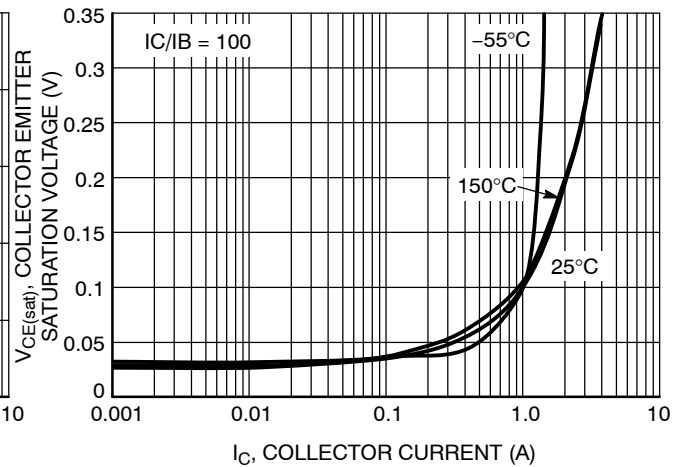


Figure 16. Collector Emitter Saturation Voltage vs. Collector Current

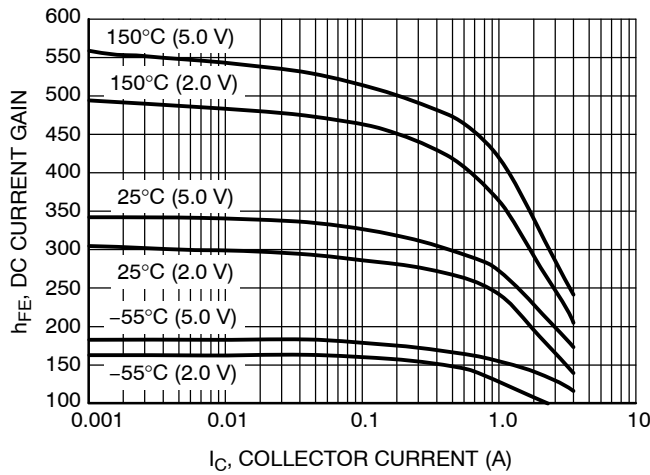


Figure 17. DC Current Gain vs. Collector Current

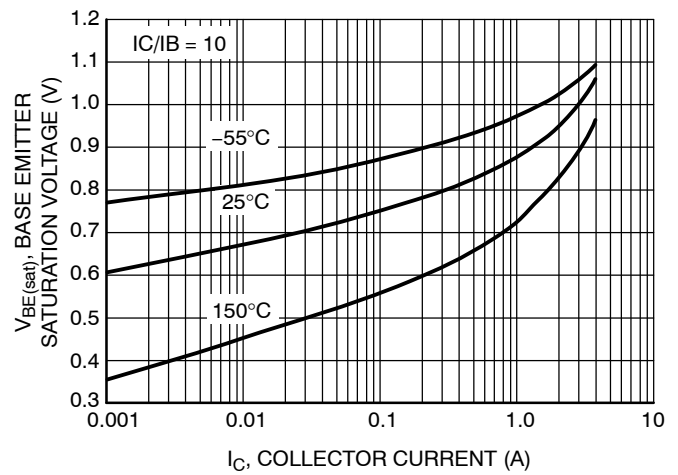


Figure 18. Base Emitter Saturation Voltage vs. Collector Current

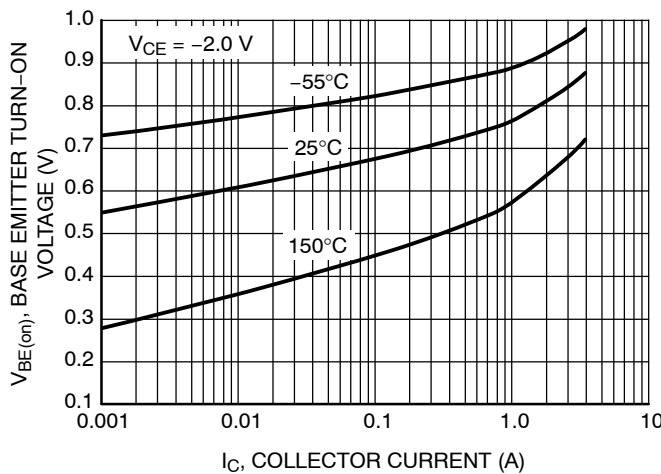


Figure 19. Base Emitter Turn-On Voltage vs. Collector Current

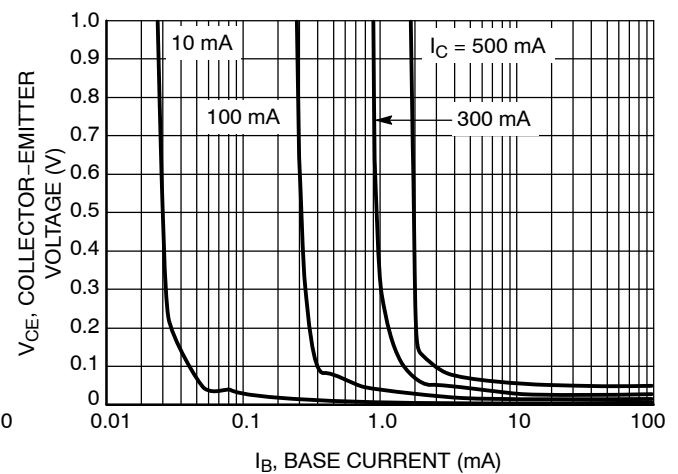


Figure 20. Saturation Region

TYPICAL CHARACTERISTICS – BJT

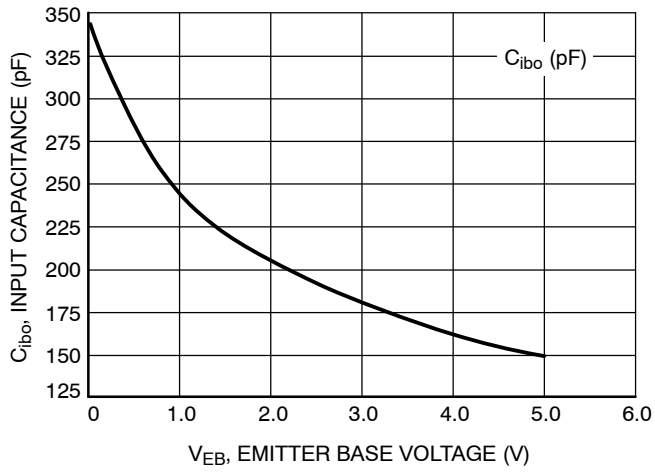


Figure 21. Input Capacitance

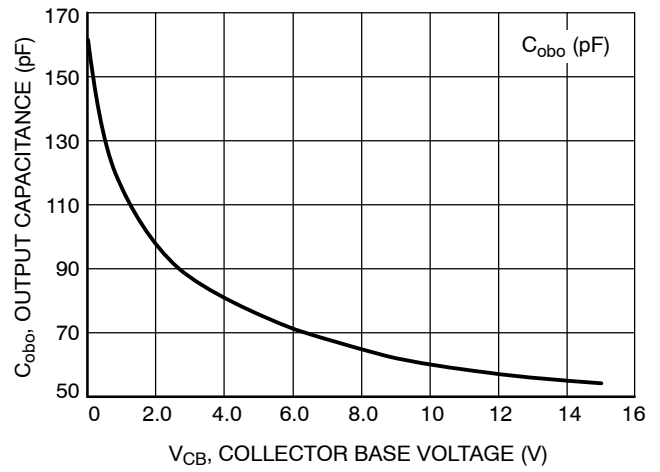
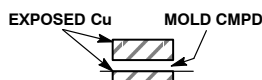
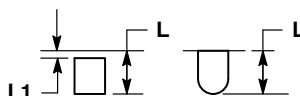
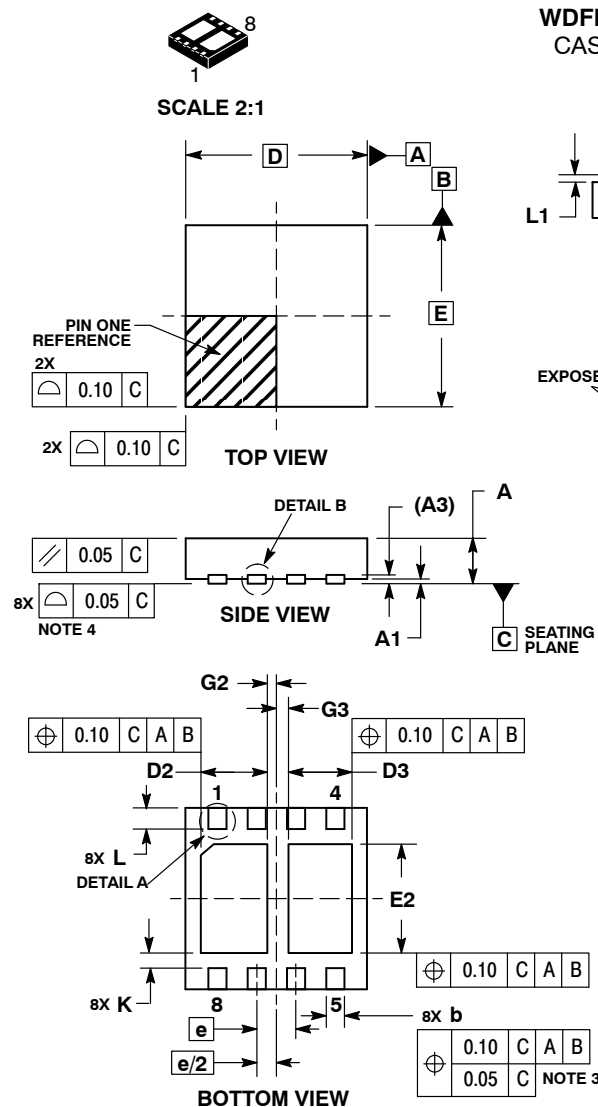


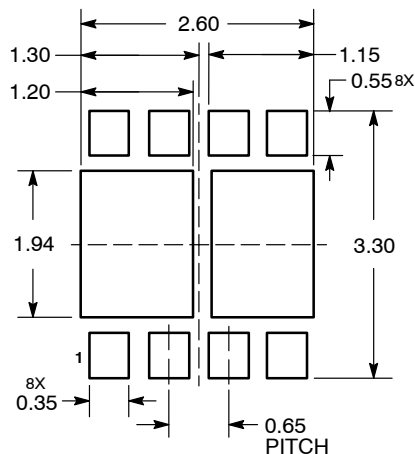
Figure 22. Output Capacitance



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
 3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm.
 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

DIM	MIN	MAX
A	0.70	0.80
A1	0.00	0.05
A3	0.20	REF
b	0.25	0.35
D	3.00	BSC
D2	1.00	1.20
D3	0.95	1.15
E	3.00	BSC
E2	1.70	1.90
e	0.65	BSC
G2	0.15	BSC
G3	0.20	BSC
K	0.20	---
L	0.25	0.45
L1	---	0.15

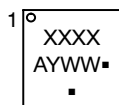
SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
▪ = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot "▪", may or may not be present.

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DESCRIPTION:	WDFN8, 3X3, 0.65P, DUAL FLAG	PAGE 1 OF 1

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